

COMMERCE  
PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

Submitted to the PTO: October 17, 2001

ATTY DOCKET NO.  
**684.2228 Div. II**

APPLICATION NO. (Div. of 09/285,672)  
**Unassigned**

APPLICANT  
**NAOTO SANO**

FILING DATE  
**Concurrently Herewith**

GROUP  
**Unassigned**

15821 U.S. PTO  
09/978035  
10/17/01

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
S ↑ ↓ ✓ S ↓	4,811,055	03/1989	Hirose			
	4,968,868	11/1990	Aketagawa	219	121.68	
	4,905,041	02/1990	Aketagawa			
	5,121,160	06/1992	Sano, et al.	355	53	
	5,250,797	10/1993	Sano, et al.	250	205	
	5,373,515	12/1994	Wakabayashi, et al.	372	20	
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	5,742,309	04/1998	Tajima, et al.			
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FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
06-260702	09/1994	Japan			Abstract

**BEST AVAILABLE COPY**

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

Grum, Franc and Richard J. Becherer. "Radiometry," Optical Radiation Measurements. Academic Press, Inc., New York: 1979. Pp. 146-147.

EXAMINER

DATE CONSIDERED

6. 25. 03

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.